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Microstructure and boundary phases of Lu–Al-doped silicon nitride by pressureless sintering

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1. Introduction

Silicon nitride (Si_3N_4) is an important engineering ceramics because of its superior mechanical properties. To improve operating temperature, highly heat resistant silicon nitride must be required. Degradation of silicon nitrides at high temperature have been considered in relation to softening of the glassy grain boundary phase and melting of secondary refractory phase. By choosing sintering additives and making refractory grain-boundary phase, high temperature strength can be improved [1,2]. Presently, the best additive for high temperature use is believed to be lutetia (Lu₂O₃) [3–8]. The hot-pressed Si₃N₄ with Lu₂O₃ additives exhibited an excellent high-temperature strength up to 1500 °C [9,10], however, the high liquid formation temperature is a major obstacle to sintering silicon nitride to full density, and suitable pressureless sintering condition has not been reported.

High temperature mechanical properties of silicon nitrides are strongly affected by softening of grain boundary glassy phase. Codoping technique is one of the promising techniques to improve mechanical properties. Al_2O_3 as an ingredient of the sintering aid tend to compromise the high-temperature properties. It has a twofold effect: (i) the lowering of the eutectic temperature of the liquid (fast densification) and (ii) the formation of a SiAION

ABSTRACT

Various silicon nitride materials were fabricated by pressureless sintering using lutetia and alumina as sintering additives. Densification behavior, microstructure, strength and formation of secondary crystalline phases were investigated. The combination of Lu₂O₃/Al₂O₃ sintering aids can promote the densification and evolution of a fine grain microstructure of Lu–Al-doped silicon nitride because of the low viscosity of the liquid. The J' phase given by Lu₄Si_{2-x}Al_xO_{7+x}N_{2-x} was considered to be secondary crystalline phase at the grain pockets. The composition with a Lu₂O₃/Al₂O₃ weight ratio 10/10 had highest strength of 690 ± 50 MPa.

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coating on the preexisting β -Si₃N₄ crystal facets [11–13]. In the present study, the relative merits of Si₃N₄ materials with the additive systems Lu₂O₃–Al₂O₃ were prepared by pressureless sintering. The effect of the sintering additives on the microstructure and the mechanical properties was investigated.

2. Experimental procedure

 α -Si₃N₄ (over 95% α -phase content and 1.5 mass% oxygen content, Shanghai, China; mean particle size: 0.5 μ m), Lu₂O₃ (99.9% purity, mean particle size: 0.5 μ m) and Al₂O₃ (99.9% purity) powders were used. The weight fractions of Lu₂O₃ + Al₂O₃ added were 7.5/0, 7.5/2.5, 7.5/5, 7.5/7.5, 10/10, and 15 wt.%/15 wt.%/0 wt%, respectively.

The above starting powder mixtures were wet milled with highpurity Si₃N₄ balls in anhydrous alcohol for 24 h in a plastic bottle. After milling, the slurry was dried, sieved, and uniaxially pressed to form rectangular bars measuring 30 mm × 30 mm × 5 mm. The green bodies were sintered in a furnace (High multi-5000, Fijidempa Co. Ltd., Osaka, Japan) at 1800 °C for 2 h with a heating rate of 15 °C/min to 1200 °C and then 10 °C/min to 1800 °C under nitrogen-gas pressures of 0.6 MPa. The samples were covered with Si₃N₄–AlN–BN powder mixture to protect the samples from decomposition and deformation.

The bulk density of the sintered specimens was measured by the Archimedes displacement method. The theoretical density of the sintered specimens was calculated according to the rule of mixtures. Crystalline phases of the resultant samples were iden-





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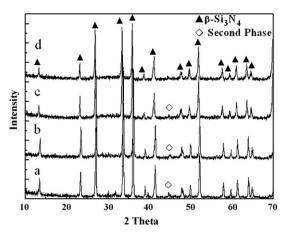


Fig. 1. X-ray diffraction patterns of Si_3N_4 ceramic with various amounts of the Lu_2O_3/Al_2O_3 additives: (a) 7.5 wt.%/5 wt.%, (b) 7.5 wt.%/7.5 wt.%, (c) 10 wt.%/10 wt.% and (d) 15 wt.%/15 wt.%.

tified by XRD (D/MAX-2400X, Rigaku Co., Tokyo, Japan) analysis. The specimens were machined into test bars for flexural strength measurement. The flexure strength was measured by three-point bending method with a 20 mm span at a cross-head speed of 0.5 mm/min at room temperature. Each final value was averaged over five measurements. Microstructure was characterized by TEM (JEM-3010) and the inter-granular phases were analyzed by using the selected-area electron diffraction (SAED). The TEM specimens were prepared by cutting and grinding the sintered specimen to a plate with a thickness of 20 μ m, then dimpling and ion beam milling.

3. Results and discussion

The XRD patterns of Lu–Al-doped Si₃N₄ ceramics are shown in Fig. 1. In Si₃N₄-Lu₂O₃-Al₂O₃ system, only the β -Si₃N₄ was detected, confirming a full transformation from α - to β -Si₃N₄. With increasing the addition of Al₂O₃, diffraction peak positions of the Si₃N₄-Lu₂O₃-Al₂O₃ composites were discernible shift, which suggested the formation of an epitaxial β -Si_{6-z}Al_zO_zN_{8-z} layer between β -Si₃N₄ and the intergranular film through simultaneous substitution of some (Si-N) bonds by (Al-O) bonds. For the materials with the Lu₂O₃-Al₂O₃ additive, an additional secondary crystalline phase thought to be a grain-boundary phase was observed. Analysis of the Lu₂O₃-stabilized material revealed that this phase could be indexed as the J' phase, an aluminumcontaining solid solution based on the J phase (Lu₄Si₂O₇N₂), which could be formed in Lu₂O₃-doped Si₃N₄ ceramics. The general formula of the J' phase is given by $Lu_4Si_{2-x}Al_xO_{7+x}N_{2-x}$ and is formed through solid solution of J phase and Lu₄Al₂O₉ which was stable in 1Lu₂O₃:1Al₂O₃ system [14], which, in the other RE-Si-Al-O-N systems, have been shown to form a continuous solid solution [15]. Huang and Chen [16] have shown that I' phase forms in other RE-Si-Al-O-N systems and that its stability increases with a decrease in ionic radius of the RE element. It had suggested that this phase probably existed for rare earth elements from dysprosium to ytterbium and that the degree of substitution, x, decreases with a decrease in ionic radius. The phase relationship in the Si₃N₄-SiO₂-Lu₂O₃ system has been shown to be very similar to those of the Si₃N₄-SiO₂-Yb₂O₃ system, which includes the formation of J phase [17], and, because the ionic radius of lutetium (0.85 Å) is very similar to that of ytterbium (0.87 Å) [18], it is not surprising that J' phase also may also exist in the Lu-Si-Al-O-N system.

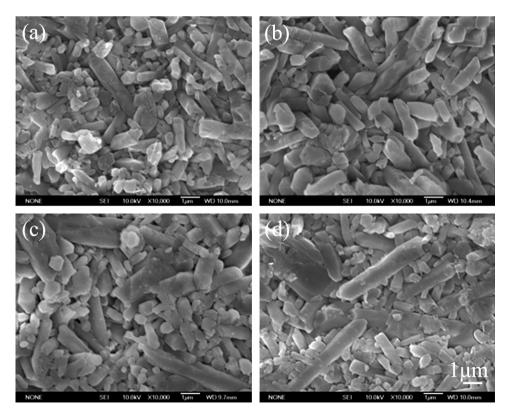


Fig. 2. SEM images of polished and NaOH-etched surfaces of Si₃N₄ ceramics with various amounts of the Lu₂O₃/Al₂O₃ additives: (a) 7.5 wt.%/5 wt.%, (b) 7.5 wt.%/7.5 wt.%, (c) 10 wt.%/10 wt.% and (d) 15 wt.%/15 wt.%.

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